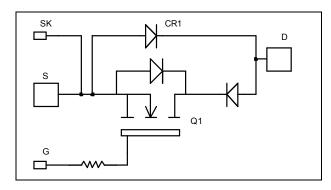
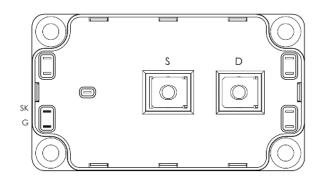


Single switch Series & parallel diodes MOSFET Power Module





$$\begin{split} \mathbf{V}_{DSS} &= 1200 \mathbf{V} \\ \mathbf{R}_{DSon} &= 100 \mathbf{m} \Omega \text{ typ } @ \text{ Tj} = 25^{\circ} \mathbf{C} \\ \mathbf{I}_{D} &= 116 \mathbf{A} @ \text{ Tc} = 25^{\circ} \mathbf{C} \end{split}$$

Application

- Welding converters
- Switched Mode Power Supplies
- Uninterruptible Power Supplies
- Motor control

Features

- Power MOS 7® MOSFETs
 - Low R_{DSon}
 - Low input and Miller capacitance
 - Low gate charge
 - Avalanche energy rated
 - Very rugged
- Kelvin source for easy drive
- Very low stray inductance
 - Symmetrical design
 - M5 power connectors
- High level of integration
- AlN substrate for MOSFET improved thermal performance

Benefits

- Outstanding performance at high frequency operation
- Direct mounting to heatsink (isolated package)
- Low junction to case thermal resistance
- Low profile
- RoHS Compliant

All ratings @ $T_i = 25^{\circ}C$ unless otherwise specified

Absolute maximum ratings

Symbol	Parameter		Max ratings	Unit
V_{DSS}	Drain - Source Breakdown Voltage		1200	V
T	Continue David Comment	$T_c = 25^{\circ}C$	116	
I_D	Continuous Drain Current	$T_c = 80$ °C	86	A
I_{DM}	Pulsed Drain current	464		
V_{GS}	Gate - Source Voltage		±30	V
R _{DSon}	Drain - Source ON Resistance		120	mΩ
P_{D}	Maximum Power Dissipation $T_c = 25^{\circ}C$		3290	W
I_{AR}	Avalanche current (repetitive and non repetitive)		24	A
E_{AR}	Repetitive Avalanche Energy		50	mJ
E_{AS}	Single Pulse Avalanche Energy		3200	IIIJ

These Devices are sensitive to Electrostatic Discharge. Proper Handling Procedures Should Be Followed. See application note APT0502 on www.microsemi.com



Electrical Characteristics

Symbol	Characteristic	Test Conditions	Min	Typ	Max	Unit
I_{DSS}	Zero Gate Voltage Drain Current	$V_{GS} = 0V, V_{DS} = 1200V$			1	mA
R _{DS(on)}	Drain – Source on Resistance	$V_{GS} = 10V, I_D = 58A$		100	120	mΩ
$V_{GS(th)}$	Gate Threshold Voltage	$V_{GS} = V_{DS}$, $I_D = 20 \text{mA}$	3		5	V
I_{GSS}	Gate – Source Leakage Current	$V_{GS} = \pm 30 \text{ V}, V_{DS} = 0 \text{ V}$			±400	nA

Dynamic Characteristics

•	Characteristic	Test Conditions	Min	Тур	Max	Unit
C_{iss}	Input Capacitance	$V_{GS} = 0V$		28.9		
C_{oss}	Output Capacitance	$V_{DS} = 25V$		4.4		nF
C_{rss}	Reverse Transfer Capacitance	f = 1MHz		0.8		
Q_{g}	Total gate Charge	$V_{GS} = 10V$		1100		
Q_{gs}	Gate – Source Charge	$V_{\text{Bus}} = 600 \text{V}$		128		nC
Q_{gd}	Gate – Drain Charge	$I_D = 116A$		716		
$T_{d(on)}$	Turn-on Delay Time	Inductive switching @ 125°C		20		ns
$T_{\rm r}$	Rise Time	$V_{GS} = 15V$		17		
$T_{d(off)}$	Turn-off Delay Time	$\begin{array}{c} \begin{array}{c} \begin{array}{c} \begin{array}{c} \\ \\ \end{array} \end{array} V_{\text{Bus}} = 800 \text{V} \\ I_{\text{D}} = 116 \text{A} \end{array}$		245		
T_{f}	Fall Time	$R_G = 1.2\Omega$		62		
Eon	Turn-on Switching Energy	Inductive switching @ 25°C		5		I
$\mathrm{E}_{\mathrm{off}}$	Turn-off Switching Energy	$V_{GS} = 15V, V_{Bus} = 800V$ $I_D = 116A, R_G = 1.2\Omega$		4.6		mJ
Eon	Turn-on Switching Energy	Inductive switching @ 125°C $V_{GS} = 15V, V_{Bus} = 800V$ $I_D = 116A, R_G = 1.2\Omega$		9.2		mJ
E_{off}	Turn-off Switching Energy			5.6		111.7
R_{thJC}	Junction to Case Thermal Resistan	ce			0.038	°C/W

Series diode ratings and characteristics

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
V_{RRM}	Maximum Peak Repetitive Reverse Voltage			1000			V
I_{RM}	Maximum Reverse Leakage Current	$V_R = 1000V$				750	μΑ
I_F	DC Forward Current		Tc = 80°C		240		A
		$I_{\rm F} = 240 A$			2	2.5	
V_{F}	Diode Forward Voltage	$I_F = 480A$			2.2		V
		$I_F = 240A$	$T_j = 125$ °C		1.7		
4			$T_j = 25^{\circ}C$		280		ma
t_{rr}		$I_F = 240A$	$T_{j} = 125^{\circ}C$		350		ns
Q _{rr}	Reverse Recovery Charge	$\begin{array}{c} \hline V_R = 667V \\ di/dt = 800A/\mu s \end{array}$	$T_j = 25$ °C		3.04		C
			$T_{j} = 125^{\circ}C$		14.4		μC
R_{thJC}	Junction to Case Thermal Resistance					0.23	°C/W



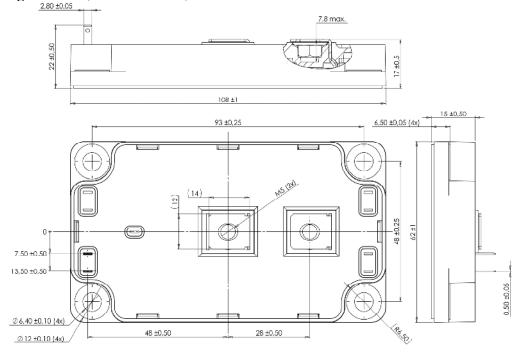
Parallel diode ratings and characteristics

Symbol	Characteristic	Test Conditions		Min	Typ	Max	Unit
V_{RRM}	Maximum Peak Repetitive Reverse Voltage			1200			V
I_{RM}	Maximum Reverse Leakage Current	$V_R = 1200V$				250	μΑ
I_F	DC Forward Current		$T_c = 80$ °C		180		A
		$I_{\rm F} = 180A$			2.5	3.5	
V_{F}	Diode Forward Voltage	$I_F = 360A$			3		V
		$I_F = 180A$	$T_j = 125$ °C		1.8		
+	Reverse Recovery Time	$I_{F} = 180A$ $V_{R} = 800V$	$T_j = 25$ °C		265		ns
t_{rr}			$T_{j} = 125^{\circ}C$		350		115
Qrr	Reverse Recovery Charge	$di/dt = 600 \text{A}/\mu\text{s}$	$T_j = 25^{\circ}C$		1.7		μC
Qrr			$T_j = 125^{\circ}C$		8.6		μС
R_{thJC}	Junction to Case Thermal Resistance					0.32	°C/W

Thermal and package characteristics

Symbol	Characteristic	Min	Max	Unit			
V_{ISOL}	RMS Isolation Voltage, any terminal to case t = 1 min, 50/60Hz					V	
T_{J}	Operating junction temperature range		-40	150			
T_{JOP}	Recommended junction temperature under	switching conditi	ons	-40	T _J max -25	°C	
T_{STG}	Storage Temperature Range		-40	125	C		
$T_{\rm C}$	Operating Case Temperature	-40	100				
Torque	Mounting torque	To heatsink	M6	3	5	N.m	
	Mounting torque For terminals M5		M5	2	3.5	11.111	
Wt	Package Weight				300	g	

SP6 Package outline (dimensions in mm)

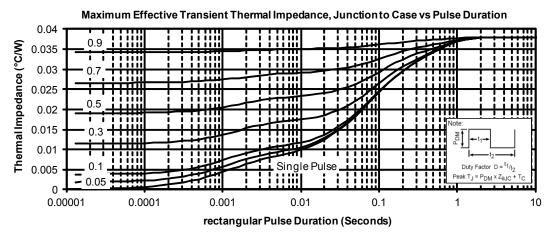


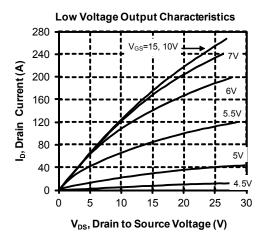
See application note APT0601 - Mounting Instructions for SP6 Power Modules on www.microsemi.com

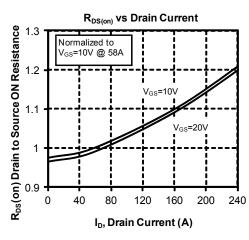
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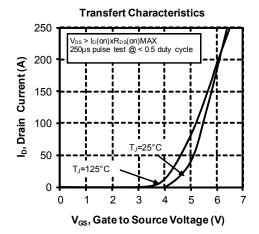


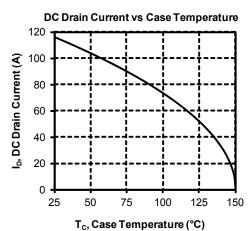
Typical Performance Curve





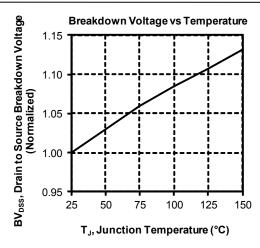


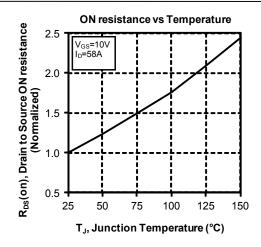


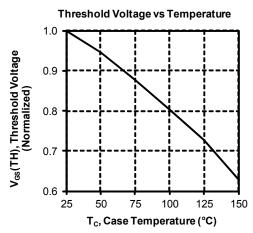


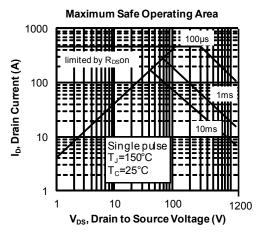
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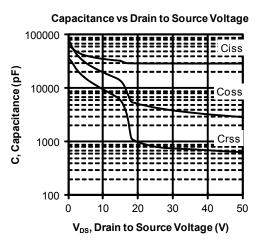


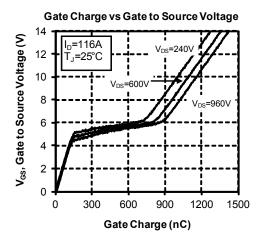




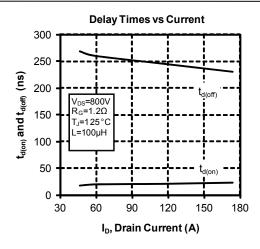


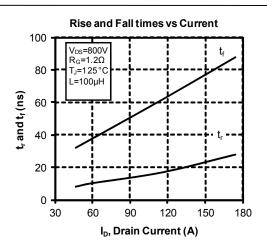


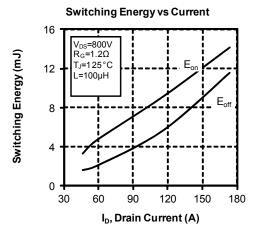


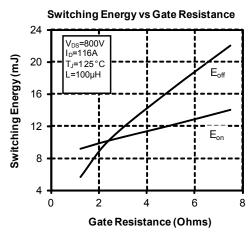


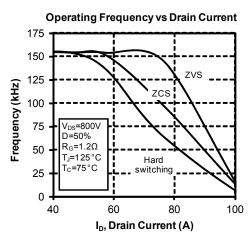


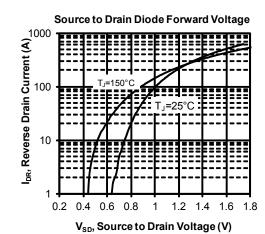














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